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(54) Title: DC BIAS EVALUATION IN AN AC COUPLED CIRCUIT VIA TRANSIENT GAIN RESPONSE

(57) Abstract: A method and system are provided for the monitoring of direct current bias, the system including switching an amplifier of known scale factor from low to high; monitoring a step change in bias generated by the gain change; measuring, the response to the bias change via appropriate peak detection logic; and determining the amount of bias present at an input based on AC response and the amplifier scale factor.

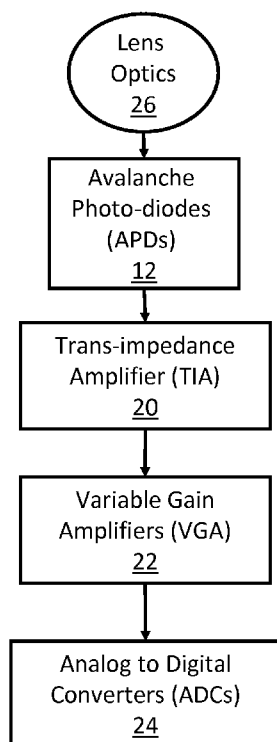


Fig. 1



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DC BIAS EVALUATION IN AN AC COUPLED CIRCUIT VIA TRANSIENT GAIN RESPONSE

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RELATED APPLICATIONS

[0001] This application claims the benefit of U.S. Provisional Application No. 61/321914, filed April 8, 2010. This application is herein incorporated by reference in their entirety for all purposes.

STATEMENT OF GOVERNMENT INTEREST

[0002] The invention was made with United States Government support under Contract No. W31P4Q-06-C-0330 awarded by the Navy. The United States Government has certain rights in this invention.

FIELD OF THE INVENTION

[0003] The invention relates to DC Bias evaluation, and more particularly, to a system and method for monitoring DC Bias in an AC coupled circuit via transient gain response.

BACKGROUND OF THE INVENTION

[0004] In a digital signal processing circuit the later gain stages are typically alternating current (AC) coupled to maximize the signal dynamic range at the analog to digital converter (ADC). There are situations where the direct current (DC) signal level after the first gain stage needs to be evaluated. If that DC bias is allowed to reach the limits of the circuit (voltage rail) it will result in signal corruption and the AC response will not be valid. Typically gain transients are not

useful since the circuit is settling from one quiescent state to another and need to be ignored. Using gain characteristics of the first gain stage allows a transition from high to low gain to generate a bias change (known transient behavior). This transition is seen as a step response to the AC circuit and the AC response can be evaluated to determine the bias present at the input to the AC coupled circuitry (verify no signal corruption).

[0005] What is needed, therefore, are techniques for determining that the input bias levels are not close to the voltage rails at the input to an AC coupled system to avoid signal corruption. Typical solutions involve the addition of monitoring circuitry that measures the DC bias directly. This requires additional circuitry and ADC inputs which are not cost effective in a product that is already in production or applications that have limited board area.

SUMMARY OF THE INVENTION

[0006] One embodiment of the present invention provides a method for the monitoring of direct current bias, the system comprising: switching an amplifier of known scale factor from low to high; monitoring a step change in bias generated by the gain change; measuring, the response to the bias change via appropriate peak detection logic; and determining the amount of bias present at an input based on AC response and the amplifier scale factor

[0007] Another embodiment of the present invention provides such method wherein the amplifier is a trans-impedance amplifier.

[0008] A further embodiment of the present invention provides such method wherein the amplifier has a scaling factor of 23x.

[0009] One embodiment of the present invention provides a method for detecting output bias levels of a sensor, the method comprising: receiving a output bias level from the sensor; amplifying the output of

the sensor with an amplifier with high and low gain options with a known amplifier scale factor; switching the amplifier from a low gain state to a high gain state; monitoring an AC response to the change in DC level that results from the switching of the gain state; and computing a DC bias based on the AC response and the amplifier scale factor

[0010] Another embodiment of the present invention provides such method wherein the output bias level is from background noise in the environment.

[0011] A further embodiment of the present invention provides such method wherein the output bias level is from the sun in a field of view of the sensor

[0012] Still another embodiment of the present invention provides such method wherein the sensor comprises at least one avalanche photodiode.

[0013] A still further embodiment of the present invention provides such method wherein the amplifier comprises at least one trans-impedance amplifier.

[0014] Yet another embodiment of the present invention provides such method wherein the amplifier has a scaling factor of 23x.

[0015] A yet further embodiment of the present invention provides such method, further comprising where the AC signal exceeds a desired value, decreasing an operating voltage to a bandwidth value.

[0016] One embodiment of the present invention provides a system for the monitoring of sun in field of view of an avalanche photodiode unit, the system comprising: an avalanche photo diode receiving optical signals from an optical lens; an amplifier configured for operation at least a high gain and a low gain; peak detectors identifying the peaks in

an AC signal generated by transition of the DC signal between high and low gain.

[0017] Another embodiment of the present invention provides such system wherein the amplifier is a variable gain amplifier.

[0018] A further embodiment of the present invention provides such system wherein the amplifier is a trans-impedance amplifier.

[0019] Still another embodiment of the present invention provides such system further comprising a second amplifier.

[0020] A still further embodiment of the present invention provides such system wherein the second amplifier is a variable gain amplifier.

[0021] The features and advantages described herein are not all-inclusive and, in particular, many additional features and advantages will be apparent to one of ordinary skill in the art in view of the drawings, specification, and claims. Moreover, it should be noted that the language used in the specification has been principally selected for readability and instructional purposes, and not to limit the scope of the inventive subject matter.

BRIEF DESCRIPTION OF THE DRAWINGS

[0022] **Figure 1** is a block diagram illustrating an overview of a method of DC bias evaluation in an AC coupled circuit via transient gain response configured in accordance with one embodiment of the present invention applied to sun in field of view of an avalanche photodiode (APD) based system.

[0023] **Figure 2** is a line chart illustrating a graph of a method of DC bias evaluation in an AC coupled circuit via transient gain response configured in accordance with one embodiment of the present invention applied to sun in field of view of an APD based system.

[0024] **Figure 3** is a flow chart for a method of evaluation in an AC coupled circuit via transient gain response configured in accordance with one embodiment of the present invention applied to sun in field of view of an APD based system

DETAILED DESCRIPTION

[0025] As illustrated in **Figure 1**, a method for DC bias evaluation in an AC coupled circuit via transient gain response, configured according to one embodiment of the present invention, is provided. In such a method, avalanche photodiodes (APDs) **12** receive photonic energy **14** and generate an output current **16**. The avalanche photo diode generates a DC current level **18** based on the amount of background energy received by the avalanche photodiode **12**. A trans-impedance amplifier **20** is used to convert the DC current level **18** into a voltage level. The trans-impedance amplifier (TIA) **20** of one embodiment of the present invention had high and low gain options and a 23x scale factor between the two settings. The TIA may then be transitioned from low to high gain via the appropriate control circuitry. The output from the TIA **20** is, in one embodiment may be further amplified with variable gain amplifiers **22** and converted from analog to digital by an analog to digital converter **24**.

[0026] In one embodiment of the present invention the TIA gain stage was transitioned from a LOW to HIGH gain configuration to generate a DC bias shift with a known 23x scale factor. This bias shift is viewed as a step response to the AC coupled circuitry and peak detection logic was used to find the maximum value from the resulting waveform. The magnitude of the waveform is directly related to the amount of DC bias voltage and can be used to avoid operating conditions (like Sun in FOV for APDs) that would damage performance. In some embodiments of the present invention, this involves determine a maximum level of DC

bias at which the AC signals will not reach the voltage rail at the input to the AC coupled circuitry. Identification of a high bias level allows the first gain stage to be adjusted back to a level to avoid corruption and/or the reporting of the error.

[0027] One embodiment of the present invention was implemented in an optical system to detect the presence of high background noise / Sun in field of view. Avalanche photo-diodes (APDs) **12** received the photonic energy from lens optics **26** and generated an output current. The APD **12** generates a DC current level based on the amount of background energy received by the APD **12**. The trans-impedance amplifier (TIA) **20** converted the current from the APD **12** into a voltage level. The TIA **20** had two gain options (High and Low) which had a 23x scale factor. Transitioning the TIA **20** from low to high gain generates a step response as illustrated in **Figure 2**. The gains of the later stages were then applied to the measured response to determine the amount of DC bias at the output of the TIA.

- Switch TIA From LOW to HIGH (VGA = 35)
 - The DC level will change from “small” to “large” and will look like an instantaneous AC signal.
 - The magnitude of the resulting AC signal will measure the DC voltage delta between TIA Low and TIA High.
 - This transition with the AC coupling will cause a “pulse” that can be detected via normal peak-detection logic.
- Data has been collected to validate this transition. The measurement data was within 1 percent of the predicted response (based on filter responses of the later gain stages).

[0028] As illustrated in **Table 1**, a test was performed wherein a spot light was used to simulate the effect of sun in the field of view of the detector. Different DC bias levels were generated. Bias levels for 7

channels were reported, allowing for evaluation of the measurements provided by the system and systemic reaction.

Table 1

Mode	Flags	TIA	Gain	Bias1	Bias2	Bias3	Bias4	Bias5	Bias6	Bias7	Spot Light
Night	0x20	High	204	447	250	291	810	66	308	216	Off
Day	0x00	High	76	3842	605	1130	942	1089	586	518	Dim, 4 feet away
SFOV	0x10	Low	180	7940	1500	2574	2113	2465	1401	1288	Bright, 4 feet away
SFOV	0x10	Low	184	4588	862	1628	1257	1266	655	651	Dim, ~3 feet away
SFOV	0x10	Low	188	4485	880	1530	1101	1158	653	693	Dim, ~3.2 feet away
Partial SFOV	0X00	High	112	4345	764	1424	1094	1177	633	628	Dim, ~3.4 feet away

[0029] As illustrated in **Figure 3** a signal is received by the avalanche photodiode system **30**. An amplifier is switched from a high gain to a low gain level **32**, the transition between high and low gain reveals a DC voltage differential that over a short or instantaneous sample period resembles a AC signal, the magnitude of which can be measured **34**. The voltage differential between the high and low gain settings can then be calculated **34** from the AC signal magnitude. Pulses in the AC signal are detected over time with peak detection logic and the bias voltage level is compared to the voltage rail to ensure AC signal will not be corrupted **38**. When the signal exceeds the threshold, automatic adjustments may be made to the operating voltage of the system to prevent saturation due to background noise. In instances where the signal saturation is high, the system may be configured to decrease V_{op} to the bandwidth value and re-evaluate (Partial SFOV mode, TIA goes HIGH) and if the saturation persists, the amplifier stays set to LOW and V_{op} stays at the bandwidth value (Full SFOV mode).

[0030] One embodiment of the present invention provides a method for the monitoring of direct current bias, the system comprising: switching an amplifier **20** of known scale factor from low to high **32**; monitoring a step change in bias generated by the gain change; measuring, the response to the bias change via appropriate peak detection logic **34**; and determining the amount of bias present at an input based on AC response and the amplifier **20** scale factor **38**. In one such embodiment the amplifier **20** is a trans-impedance amplifier **20**. Likewise, in one embodiment, the amplifier **20** has a scaling factor of 23x.

[0031] One embodiment of the present invention provides a method for detecting output bias levels of a sensor, the method comprising: receiving a output bias level from the sensor **30**; amplifying the output of the sensor **12** with an amplifier **20** with high and low gain options with a known amplifier scale factor and switching the amplifier **20** from a low gain state to a high gain state **32**; monitoring an AC response to the change in DC level that results from the switching of the gain state **36**; and computing a DC bias based on the AC response and the amplifier **20** scale factor **38**.

[0032] Such a method could be utilized where output bias level is from background noise in the environment or from the sun in a field of view of the sensor. The sensor **12** may be at least one avalanche photodiode, and the amplifier **20** may be at least one trans-impedance amplifier or may have a scaling factor of 23x.

[0033] Where the AC signal exceeds a desired value, the method may include decreasing an operating voltage to a bandwidth value.

[0034] One embodiment of the present invention provides a system for the monitoring of sun in field of view of an avalanche photodiode unit, the system comprising: an avalanche photo diode **12** receiving optical

signals from an optical lens **26**; an amplifier **20** configured for operation at least a high gain and a low gain; peak detectors identifying the peaks in an AC signal generated by transition of the DC signal between high and low gain.

[0035] Another embodiment of the present invention provides such system wherein the amplifier **20** is a variable gain amplifier or a trans-impedance amplifier. In an alternative embodiment of the present invention a second amplifier **22** may be provided which may be a variable gain amplifier.

[0036] The foregoing description of the embodiments of the invention has been presented for the purposes of illustration and description. It is not intended to be exhaustive or to limit the invention to the precise form disclosed. Many modifications and variations are possible in light of this disclosure. It is intended that the scope of the invention be limited not by this detailed description, but rather by the claims appended hereto.

CLAIMS

What is claimed is:

1 1. A method for the monitoring of direct current bias, the system
2 comprising:

3 switching an amplifier of known scale factor from low to high;
4 monitoring a step change in bias generated by said gain change;
5 measuring, the response to said bias change via appropriate peak
6 detection logic; and
7 determining the amount of bias present at an input based on AC
8 response and the amplifier scale factor.

1 2. The method of claim 1 wherein said amplifier is a trans impedance
2 amplifier.

1 3. The method of claim 1 wherein said amplifier has a scaling factor
2 of 23x.

1 4. A method for detecting output bias levels of a sensor, said method
2 comprising:

3 receiving a output bias level from said sensor;
4 amplifying the output of said sensor with an amplifier with high and
5 low gain options with a known amplifier scale factor;
6 switching said amplifier from a low gain state to a high gain state;
7 monitoring an AC response to the change in DC level that results
8 from said switching of said gain state; and
9 computing a DC bias based on said AC response and said amplifier
10 scale factor.

1 5. The method of claim 4 wherein said output bias level is from
2 background noise in the environment.

3 6. The method of claim 4 wherein said output bias level is from the
4 sun in a field of view of the sensor.

5 7. The method of claim 5 wherein said sensor comprises at least
6 one avalanche photodiode.

1 8. The method of claim 4 wherein said amplifier comprises at least
2 one trans-impedance amplifier.

1 9. The method of claim 4 wherein said amplifier has a scaling factor
2 of 23x.

1 10. The method according to claim 9, further comprising where said
2 AC signal exceeds a desired value, decreasing an operating voltage to a
3 bandwidth value.

1 11. A system for the monitoring of sun in field of view of an
2 avalanche photodiode unit, said system comprising:

3 an avalanche photo diode receiving optical signals from an optical
4 lens;

5 an amplifier configured for operation at least a high gain and a low
6 gain;

7 peak detectors identifying the peaks in an AC signal generated by
8 transition of the DC signal between high and low gain.

1 12. The system according to claim 11 wherein said amplifier is a
2 variable gain amplifier.

1 13. The system according to claim 11 wherein said amplifier is a
2 trans-impedance amplifier.

1 14. The system of claim 11 further comprising a second amplifier.

1 15. The system of claim 14 wherein said second amplifier is a
2 variable gain amplifier.

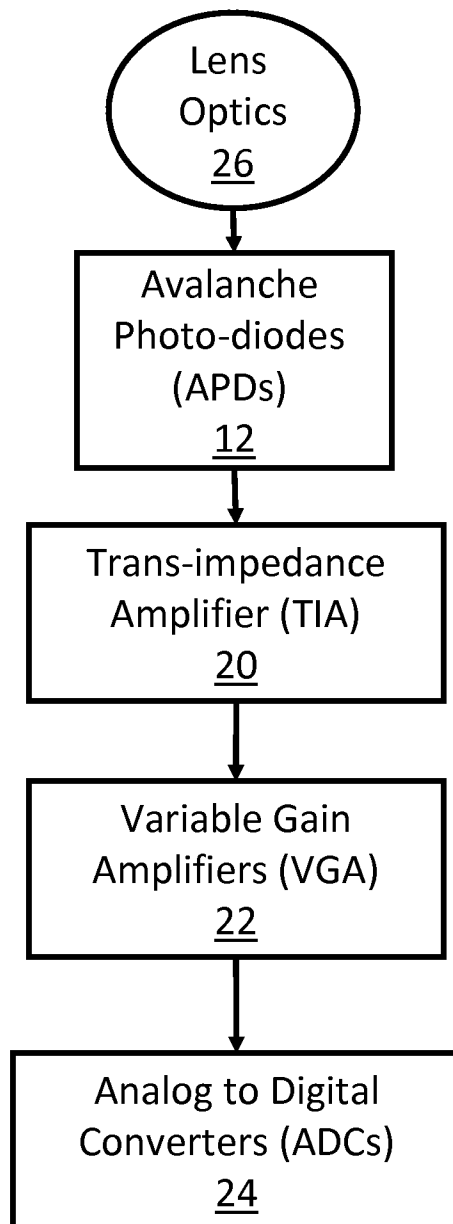


Fig. 1

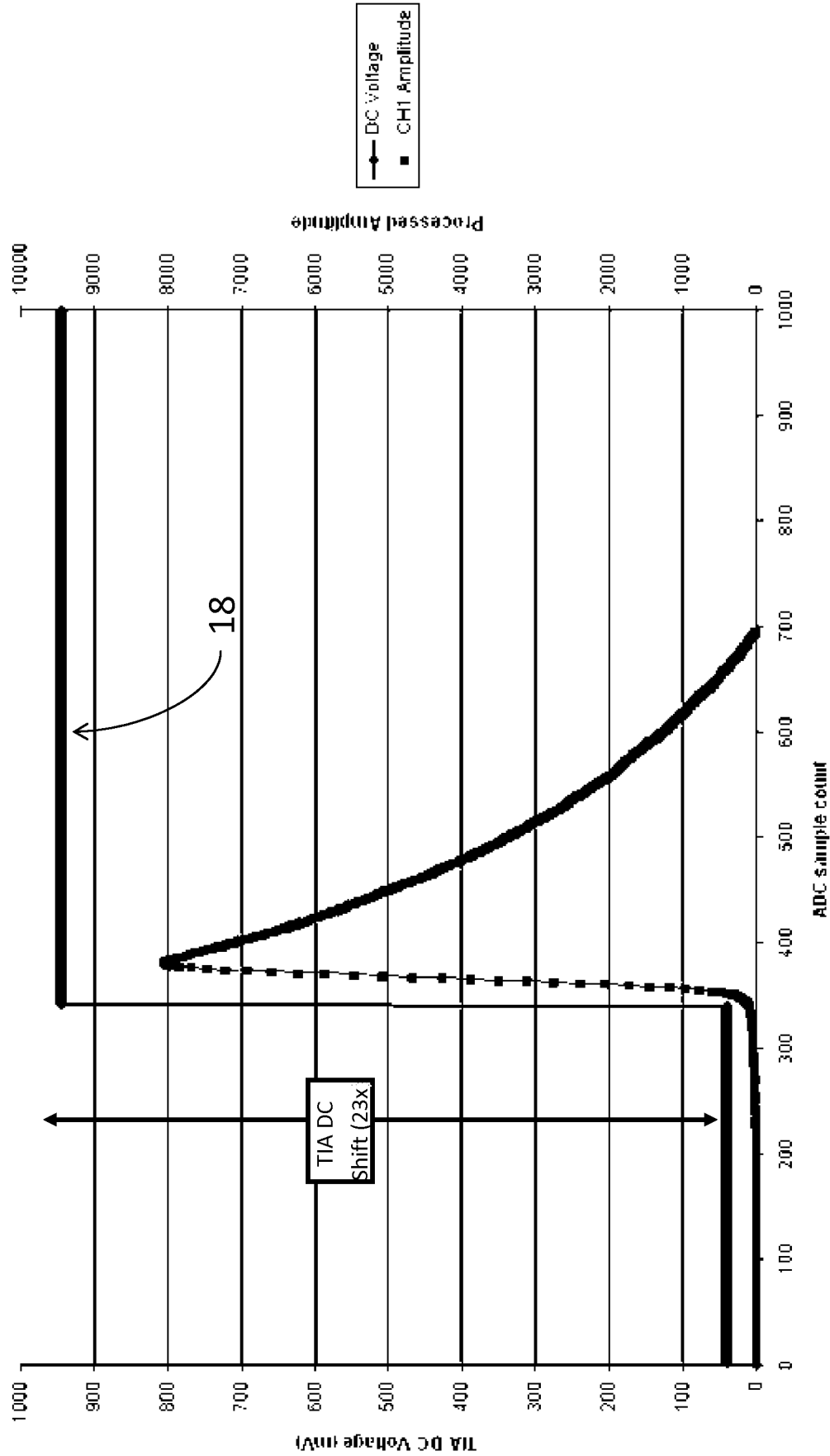


Figure 2

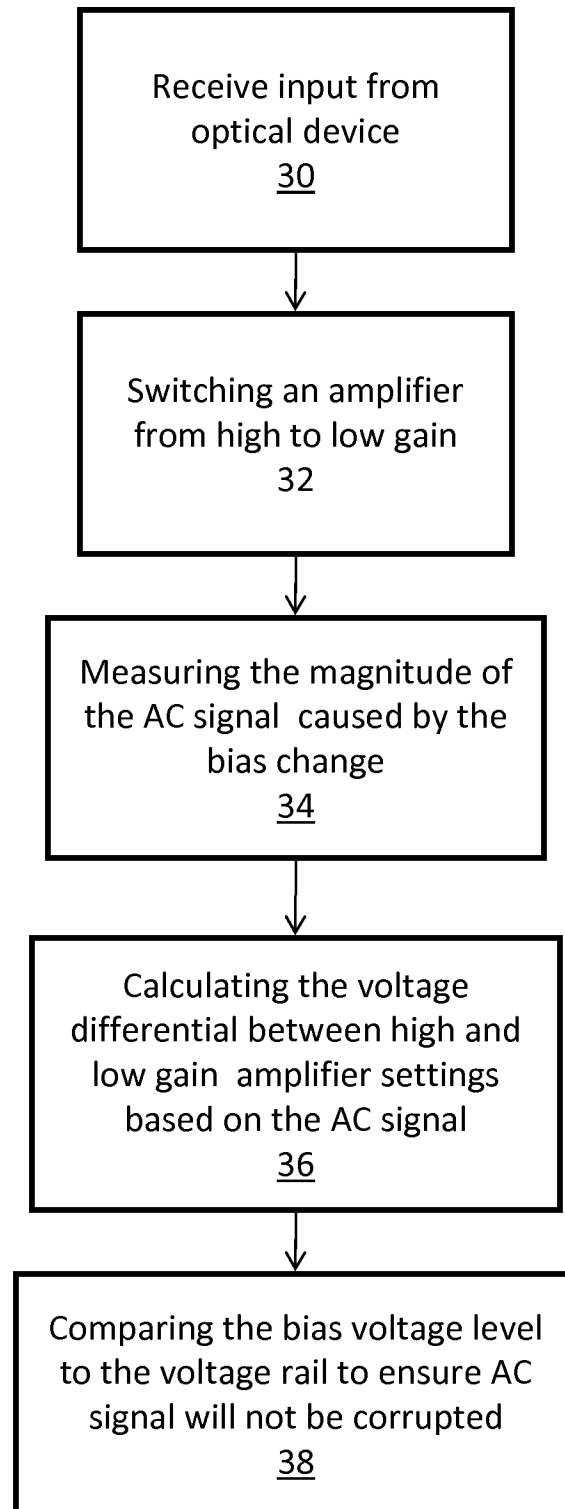


Figure 3